## Notice of References Cited

Application/Control No.

10/015,033

Examiner

Hiep Nguyen

Applicant(s)/Patent Under Reexamination CHUNG, MICHAEL S.C.

Art Unit
Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,752,699	06-1988	Cranford, Jr. et al.	327/100
	В	US-5,006,974	04-1991	Kazerounian et al.	363/60
	С	US-6,259,612	07-2001	Itoh	363/60
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	_				
	Q					
	R					,
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

BEST AVAILABLE COPY